

# Diode

Silicon Carbide Schottky Diode

# IDH20G120C5

5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

## IDH20G120C5

Rev. 2.2 2021-03-01

# Industrial Power Control



## CoolSiC<sup>™</sup> SiC Schottky Diode

#### Features:

- Revolutionary semiconductor material Silicon Carbide
- No reverse recovery current / No forward recovery
- Temperature independent switching behavior •
- Low forward voltage even at high operating temperature •
- Tight forward voltage distribution •
- Excellent thermal performance •
- Extended surge current capability
- Specified dv/dt ruggedness •
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Pb-free lead plating; RoHS compliant

#### **Benefits**

- System efficiency improvement over Si diodes •
- Enabling higher frequency / increased power density solutions
- System size / cost savings due to reduced heatsink requirements and smaller magnetics
- Reduced EMI
- Highest efficiency across the entire load range
- Robust diode operation during surge events
- High reliability
- RelatedLinks: www.infineon.com/sic

#### **Applications**

- Solar inverters
- Uninterruptable power supplies
- Motor drives
- **Power Factor Correction**

#### Package pin definitions

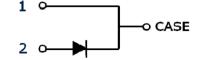
- Pin 1 and backside cathode
- Pin 2 anode



#### **Key Performance and Package Parameters**

Туре	V <sub>DC</sub>	I <sub>F</sub>	Q <sub>C</sub>	<b>T</b> <sub>j,max</sub>	Marking	Package
IDH20G120C5	1200V	20A	82nC	175°C	D2012C5	PG-TO220-2-1

1) J-STD20 and JESD22











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#### **Maximum ratings**

Parameter	Symbol	Value	Unit	
Repetitive peak reverse voltage	V <sub>RRM</sub>	1200	V	
Continues forward current for $R_{th(j-c,max)}$ $T_c = 150^{\circ}C, D=1$ $T_c = 135^{\circ}C, D=1$ $T_c = 25^{\circ}C, D=1$	IF	20 27 56	A	
Surge non-repetitive forward current, sine halfwave $T_{C}=25^{\circ}C$ , $t_{p}=10ms$ $T_{C}=150^{\circ}C$ , $t_{p}=10ms$	<i>I</i> f,sm	198 168	A	
Non-repetitive peak forward current $T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm P} = 10 \ \mu{\rm s}$	<i>I</i> F,max	1200	А	
i <sup>2</sup> t value $T_{\rm C} = 25^{\circ}$ C, $t_{\rm p}$ =10 ms $T_{\rm C} = 150^{\circ}$ C, $t_{\rm p}$ =10 ms	∫ i²dt	195 140	A²s	
Diode d <i>v</i> /d <i>t</i> ruggedness <i>V</i> <sub>R</sub> =0960V	dv/dt	150	V/ns	
Power dissipation $T_{\rm C} = 25^{\circ}{\rm C}$	Ptot	330	W	
Operating and storage temperature	T <sub>j</sub> ;T <sub>stg</sub>	-55175	°C	
Soldering temperature, wavesoldering only allowed at leads, 1.6mm (0.063 in.) from case for 10 s	T <sub>sold</sub>	260	°C	
Mounting torque M3 and M4 screws	М	0.7	Nm	

#### **Thermal Resistances**

Parameter	Symbol	Conditions min.		Value	Unit	
Falametei			min.	typ.	max.	Unit
Characteristic						
Diode thermal resistance, junction – case	R <sub>th(j-c)</sub>		-	0.35	0.46	K/W
Thermal resistance, junction – ambient	R <sub>th(j-a)</sub>	leaded	-	-	62	K/W



#### **Electrical Characteristics**

#### Static Characteristics, at $T_j=25^{\circ}C$ , unless otherwise specified

Parameter	Symbol	Conditions min.		Value		Unit
Farameter	Symbol		min.	typ.	max.	Onit
Static Characteristic						
DC blocking voltage	VDC	$T_{\rm j} = 25^{\circ}{\rm C}$	1200	-	-	V
Diode forward voltage	VF	<i>I</i> ⊧= 20A, <i>T</i> j=25°C	-	1.5	1.8	V
Didde forward voltage		<i>I</i> ⊧= 20A, <i>T</i> j=150°C	-	2.0	2.6	
Reverse current	I <sub>R</sub>	<i>V</i> <sub>R</sub> =1200V, <i>T</i> <sub>j</sub> =25°C		8.5	123	μΑ
		<i>V</i> <sub>R</sub> =1200V, <i>T</i> <sub>j</sub> =150°C		44	630	

#### Dynamic Characteristics, at Tj=25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
Farameter			min.	typ.	max.	Onit
Dynamic Characteristics						
Total capacitive charge		<i>V</i> <sub>R</sub> =800V, <i>T</i> <sub>j</sub> =150°C				
	Qc	$Q_C = \int_0^{V_R} C(V) dV$	-	82	-	nC
		<i>V</i> <sub>R</sub> =1 V, <i>f</i> =1 MHz	-	1050	-	
Total Capacitance	С	<i>V</i> <sub>R</sub> =400 V, <i>f</i> =1 MHz	-	74	-	pF
		<i>V</i> <sub>R</sub> =800 V, <i>f</i> =1 MHz	-	59	-	



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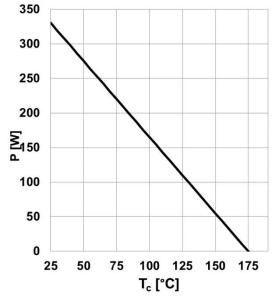


Figure 1. Power dissipation as a function of case temperature,  $P_{tot}=f(T_C, R_{th(j-c),max})$ 

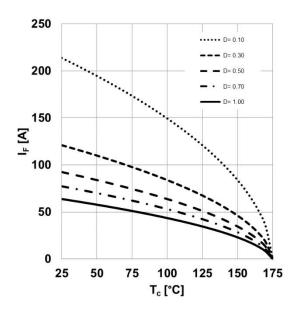
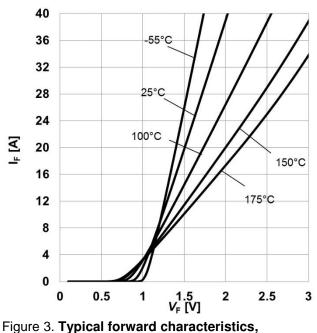
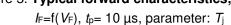


Figure 2. Diode forward current as function of temperature,  $T_j \le 175^\circ$ C,  $R_{th(j-c),max}$ , parameter D=duty cycle,  $V_{th}$ ,  $R_{diff}$  @  $T_j=175^\circ$ C





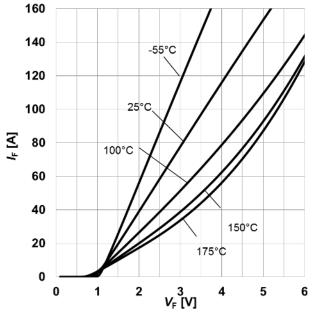


Figure 4. **Typical forward characteristics in surge current**, *I*<sub>F</sub>=f(*V*<sub>F</sub>), *t*<sub>p</sub>= 10 µs, parameter: *T*<sub>j</sub>



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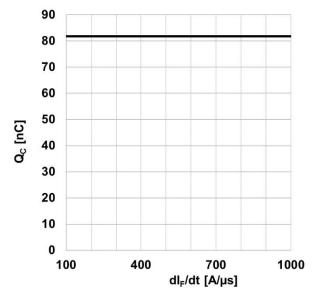
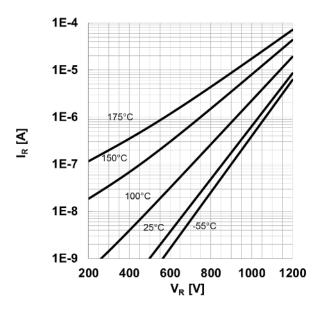
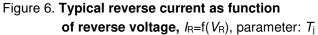
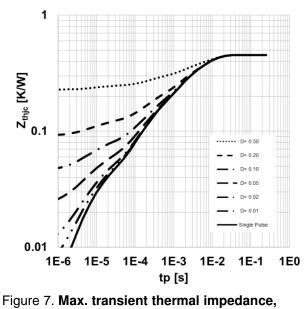
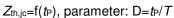


Figure 5. **Typical capacitive charge as function** of current slope<sup>1</sup>, *Q*<sub>C</sub>=f(*dl*<sub>F</sub>/*dt*), *T*<sub>j</sub>=150°C 1) Only capacitive charge, guaranteed by design.









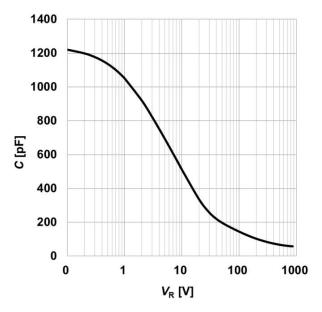
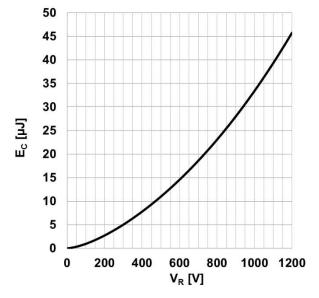
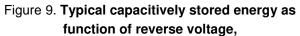


Figure 8. **Typical capacitance as function of** reverse voltage, *C*=f(*V*<sub>R</sub>); *T*<sub>j</sub>=25°C; *f*=1 MHz



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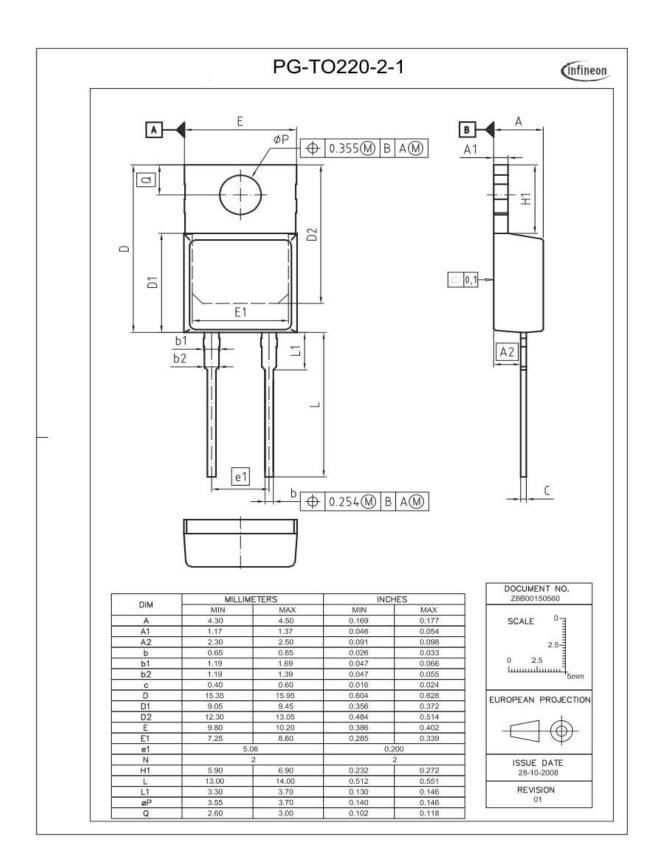


$$E_C = \int_0^{V_R} C(V) V dV$$



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#### **Revision History**

IDH20G120C5

#### Revision: 2021-03-01, Rev. 2.2

Previous Revision:					
Revision	n Date Subjects (major changes since last version)				
2.0	2015-09-03	Final data sheet			
2.1	2017-07-21	Editorial Changes			
2.2	2021-03-01	Increased dv/dt ruggedness			

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